



# STD19NE06L

## N-CHANNEL 60V - 0.038 Ω - 19A IPAK/DPAK STripFET™ POWER MOSFET

| TYPE       | V <sub>DSS</sub> | R <sub>DS(on)</sub> | I <sub>D</sub> |
|------------|------------------|---------------------|----------------|
| STD19NE06L | 60 V             | <0.05 Ω             | 19 A           |

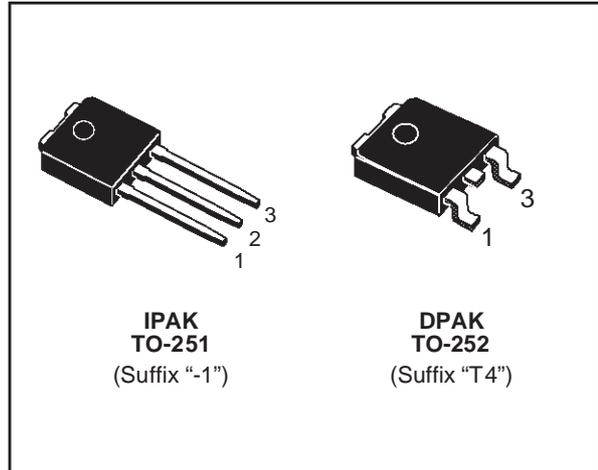
- TYPICAL R<sub>DS(on)</sub> = 0.038 Ω
- 100% AVALANCHE TESTED
- LOW GATE CHARGE
- THROUGH-HOLE IPAK (TO-251) POWER PACKAGE IN TUBE (SUFFIX "-1")
- SURFACE-MOUNTING DPAK (TO-252) POWER PACKAGE IN TAPE & REEL (SUFFIX "T4")

### DESCRIPTION

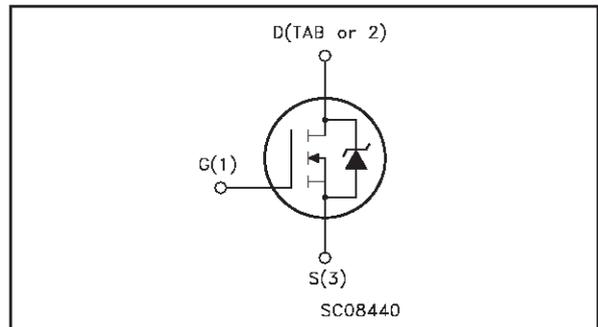
This Power MOSFET is the latest development of STMicroelectronics unique "Single Feature Size™" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

### APPLICATIONS

- HIGH CURRENT, HIGH SPEED SWITCHING
- SOLENOID AND RELAY DRIVERS
- MOTOR CONTROL, AUDIO AMPLIFIERS
- DC-DC & DC-AC CONVERTERS



### INTERNAL SCHEMATIC DIAGRAM



### ABSOLUTE MAXIMUM RATINGS

| Symbol              | Parameter                                            | Value      | Unit |
|---------------------|------------------------------------------------------|------------|------|
| V <sub>DS</sub>     | Drain-source Voltage (V <sub>GS</sub> = 0)           | 60         | V    |
| V <sub>DGR</sub>    | Drain-gate Voltage (R <sub>GS</sub> = 20 kΩ)         | 60         | V    |
| V <sub>GS</sub>     | Gate- source Voltage                                 | ± 20       | V    |
| I <sub>D</sub>      | Drain Current (continuous) at T <sub>C</sub> = 25°C  | 19         | A    |
| I <sub>D</sub>      | Drain Current (continuous) at T <sub>C</sub> = 100°C | 13         | A    |
| I <sub>DM</sub> (●) | Drain Current (pulsed)                               | 76         | A    |
| P <sub>tot</sub>    | Total Dissipation at T <sub>C</sub> = 25°C           | 70         | W    |
|                     | Derating Factor                                      | 0.3        | W/°C |
| E <sub>AS</sub> (1) | Single Pulse Avalanche Energy                        | 50         | mJ   |
| T <sub>stg</sub>    | Storage Temperature                                  | -55 to 175 | °C   |
| T <sub>j</sub>      | Max. Operating Junction Temperature                  |            |      |

(●) Pulse width limited by safe operating area

(1) Starting T<sub>j</sub> = 25 °C, I<sub>D</sub> = I<sub>AR</sub>, V<sub>DD</sub> = 35 V

## STD19NE06L

### THERMAL DATA

|                |                                                |     |      |      |
|----------------|------------------------------------------------|-----|------|------|
| Rthj-case      | Thermal Resistance Junction-case               | Max | 2.14 | °C/W |
| Rthj-amb       | Thermal Resistance Junction-ambient            | Max | 100  | °C/W |
| Rthc-sink      | Thermal Resistance Case-sink                   | Typ | 1.5  | °C/W |
| T <sub>l</sub> | Maximum Lead Temperature For Soldering Purpose |     | 300  | °C   |

### ELECTRICAL CHARACTERISTICS (T<sub>case</sub> = 25 °C unless otherwise specified)

#### OFF

| Symbol               | Parameter                                             | Test Conditions                                                                     | Min. | Typ. | Max.    | Unit     |
|----------------------|-------------------------------------------------------|-------------------------------------------------------------------------------------|------|------|---------|----------|
| V <sub>(BR)DSS</sub> | Drain-source Breakdown Voltage                        | I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0                                        | 60   |      |         | V        |
| I <sub>DSS</sub>     | Zero Gate Voltage Drain Current (V <sub>GS</sub> = 0) | V <sub>DS</sub> = Max Rating<br>V <sub>DS</sub> = Max Rating T <sub>C</sub> = 125°C |      |      | 1<br>10 | μA<br>μA |
| I <sub>GSS</sub>     | Gate-body Leakage Current (V <sub>DS</sub> = 0)       | V <sub>GS</sub> = ± 20 V                                                            |      |      | ±100    | nA       |

#### ON (\*)

| Symbol              | Parameter                         | Test Conditions                                                                               | Min. | Typ.           | Max.         | Unit   |
|---------------------|-----------------------------------|-----------------------------------------------------------------------------------------------|------|----------------|--------------|--------|
| V <sub>GS(th)</sub> | Gate Threshold Voltage            | V <sub>DS</sub> = V <sub>GS</sub> I <sub>D</sub> = 250 μA                                     | 1    | 1.7            | 2.5          | V      |
| R <sub>DS(on)</sub> | Static Drain-source On Resistance | V <sub>GS</sub> = 5 V I <sub>D</sub> = 9.5 A<br>V <sub>GS</sub> = 10 V I <sub>D</sub> = 9.5 A |      | 0.048<br>0.038 | 0.06<br>0.05 | Ω<br>Ω |

#### DYNAMIC

| Symbol                                                   | Parameter                                                               | Test Conditions                                                                           | Min. | Typ.              | Max. | Unit           |
|----------------------------------------------------------|-------------------------------------------------------------------------|-------------------------------------------------------------------------------------------|------|-------------------|------|----------------|
| g <sub>fs</sub> (*)                                      | Forward Transconductance                                                | V <sub>DS</sub> > I <sub>D(on)</sub> × R <sub>DS(on)max</sub> ,<br>I <sub>D</sub> = 9.5 A | 7    | 14                |      | S              |
| C <sub>iss</sub><br>C <sub>oss</sub><br>C <sub>rss</sub> | Input Capacitance<br>Output Capacitance<br>Reverse Transfer Capacitance | V <sub>DS</sub> = 25V, f = 1 MHz, V <sub>GS</sub> = 0                                     |      | 1350<br>195<br>58 |      | pF<br>pF<br>pF |

**ELECTRICAL CHARACTERISTICS** (continued)

**SWITCHING ON**

| Symbol                        | Parameter                                                    | Test Conditions                                                                                                         | Min. | Typ.          | Max. | Unit           |
|-------------------------------|--------------------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------|------|---------------|------|----------------|
| $t_{d(on)}$<br>$t_r$          | Turn-on Delay Time<br>Rise Time                              | $V_{DD} = 30\text{ V}$ $I_D = 15\text{ A}$<br>$R_G = 4.7\ \Omega$ $V_{GS} = 4.5\text{ V}$<br>(Resistive Load, Figure 3) |      | 25<br>105     |      | ns<br>ns       |
| $Q_g$<br>$Q_{gs}$<br>$Q_{gd}$ | Total Gate Charge<br>Gate-Source Charge<br>Gate-Drain Charge | $V_{DD} = 48\text{ V}$ $I_D = 30\text{ A}$ $V_{GS} = 5\text{ V}$                                                        |      | 20<br>8<br>10 | 28   | nC<br>nC<br>nC |

**SWITCHING OFF**

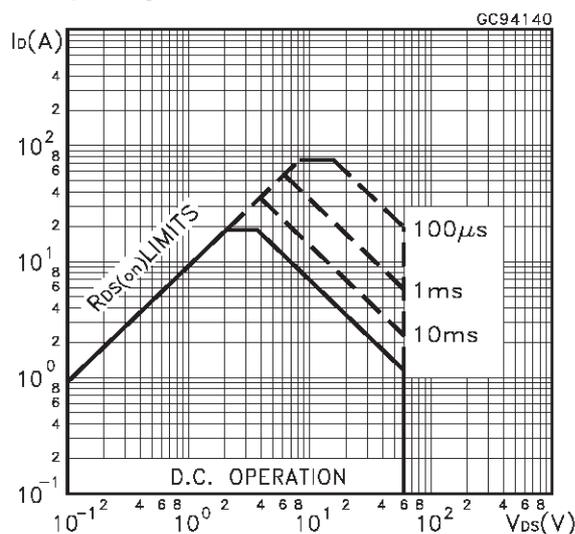
| Symbol                           | Parameter                                             | Test Conditions                                                                                                            | Min. | Typ.           | Max. | Unit           |
|----------------------------------|-------------------------------------------------------|----------------------------------------------------------------------------------------------------------------------------|------|----------------|------|----------------|
| $t_{d(off)}$<br>$t_f$            | Turn-off Delay Time<br>Fall Time                      | $V_{DD} = 30\text{ V}$ $I_D = 15\text{ A}$<br>$R_G = 4.7\ \Omega$ , $V_{GS} = 4.5\text{ V}$<br>(Resistive Load, Figure 3)  |      | 50<br>20       |      | ns<br>ns       |
| $t_r(V_{off})$<br>$t_f$<br>$t_c$ | Off-voltage Rise Time<br>Fall Time<br>Cross-over Time | $V_{clamp} = 48\text{ V}$ $I_D = 12\text{ A}$<br>$R_G = 4.7\ \Omega$ , $V_{GS} = 5\text{ V}$<br>(Inductive Load, Figure 5) |      | 15<br>40<br>60 |      | ns<br>ns<br>ns |

**SOURCE DRAIN DIODE**

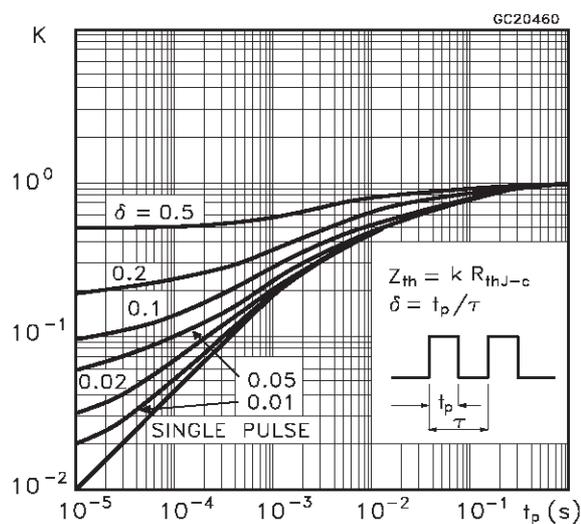
| Symbol                            | Parameter                                                                    | Test Conditions                                                                                                                               | Min. | Typ.              | Max.     | Unit                     |
|-----------------------------------|------------------------------------------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------|------|-------------------|----------|--------------------------|
| $I_{SD}$<br>$I_{SDM} (\bullet)$   | Source-drain Current<br>Source-drain Current (pulsed)                        |                                                                                                                                               |      |                   | 19<br>76 | A<br>A                   |
| $V_{SD} (*)$                      | Forward On Voltage                                                           | $I_{SD} = 30\text{ A}$ $V_{GS} = 0$                                                                                                           |      |                   | 1.5      | V                        |
| $t_{rr}$<br>$Q_{rr}$<br>$I_{RRM}$ | Reverse Recovery Time<br>Reverse Recovery Charge<br>Reverse Recovery Current | $I_{SD} = 30\text{ A}$ $di/dt = 100\text{ A}/\mu\text{s}$<br>$V_{DD} = 30\text{ V}$ $T_j = 150^\circ\text{C}$<br>(see test circuit, Figure 5) |      | 80<br>0.18<br>4.5 |          | ns<br>$\mu\text{C}$<br>A |

(\*)Pulsed: Pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5 %.  
 (•)Pulse width limited by safe operating area.

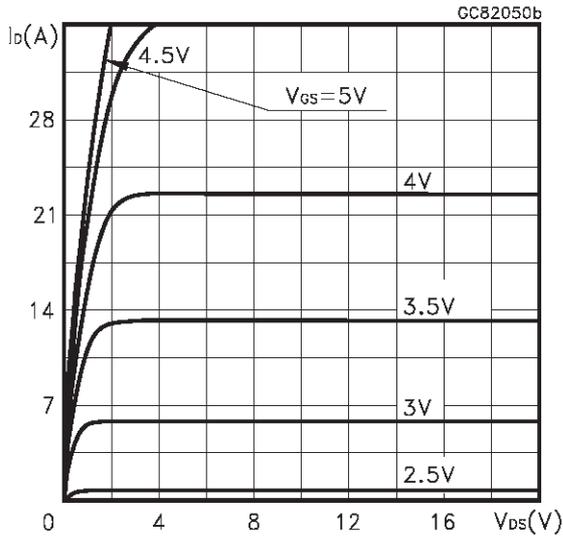
**Safe Operating Area**



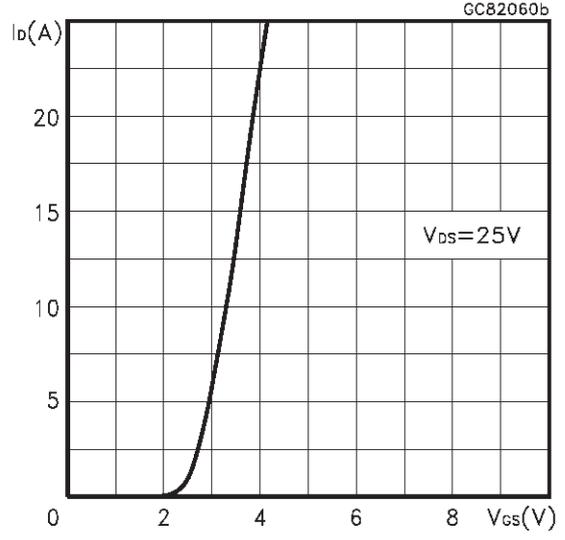
**Thermal Impedance**



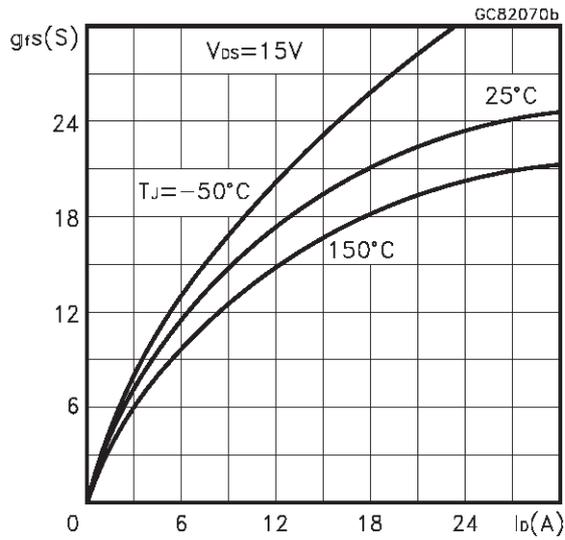
Output Characteristics



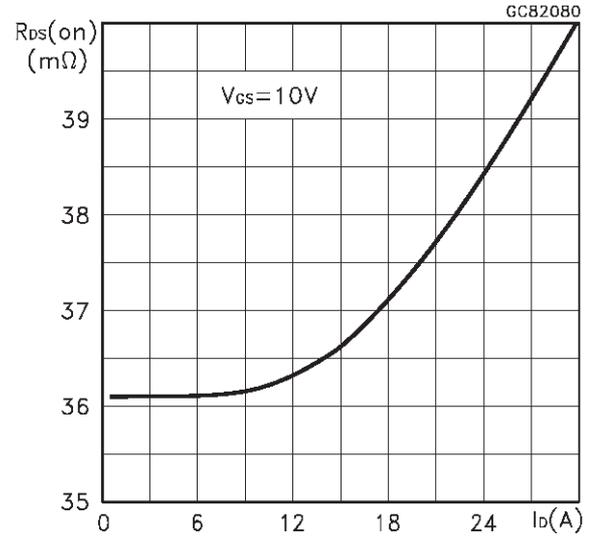
Transfer Characteristics



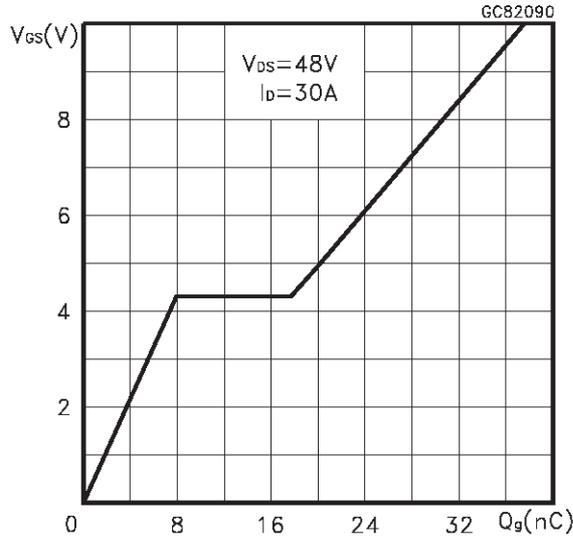
Transconductance



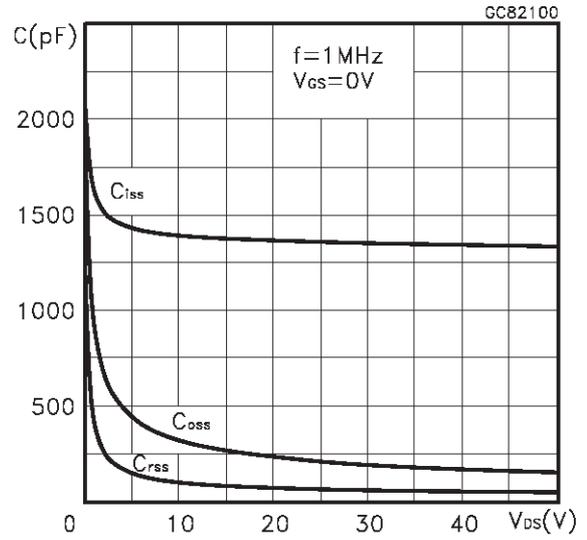
Static Drain-source On Resistance



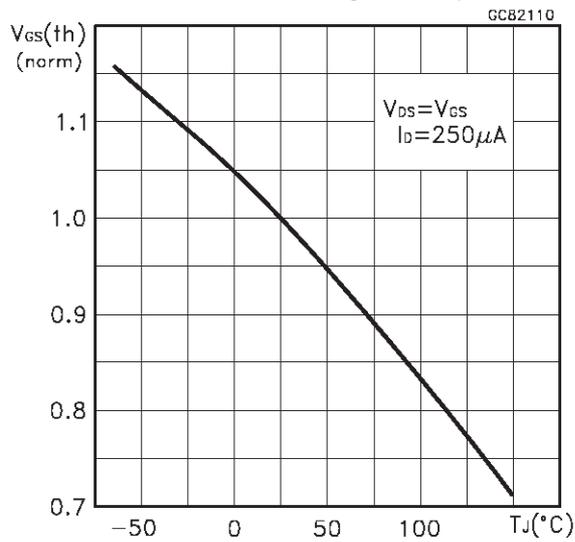
Gate Charge vs Gate-source Voltage



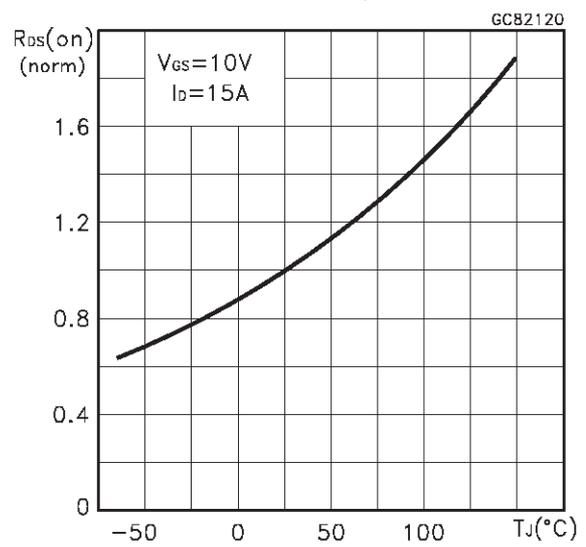
Capacitance Variations



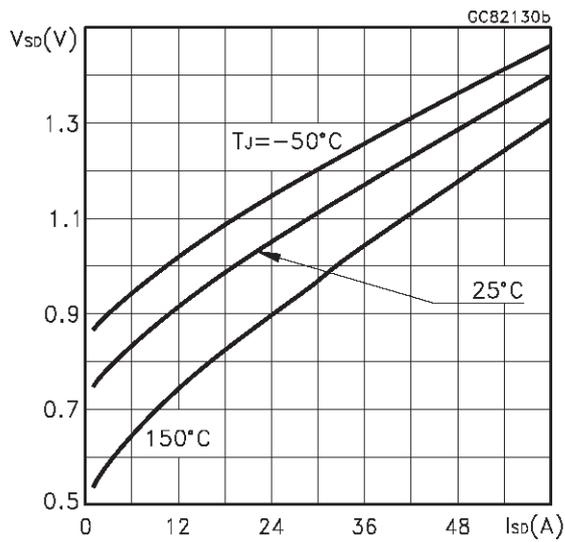
Normalized Gate Threshold Voltage vs Temperature



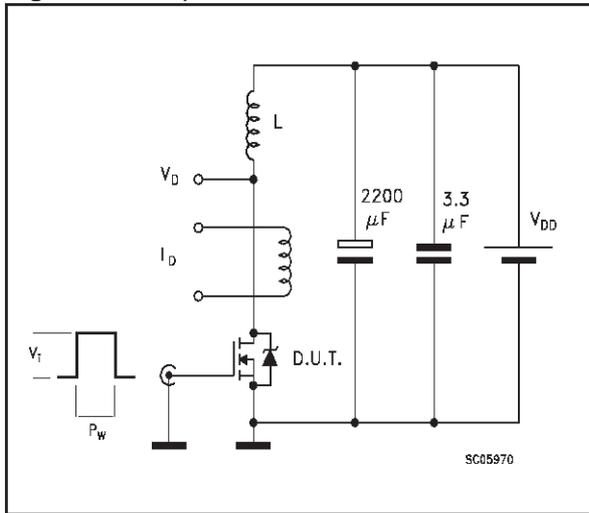
Normalized on Resistance vs Temperature



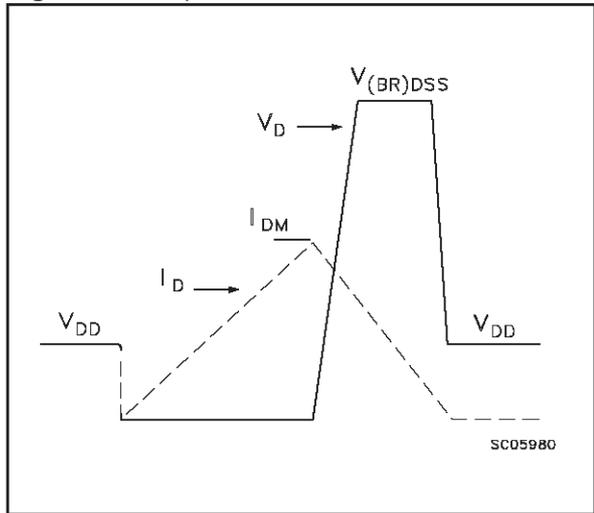
Source-drain Diode Forward Characteristics



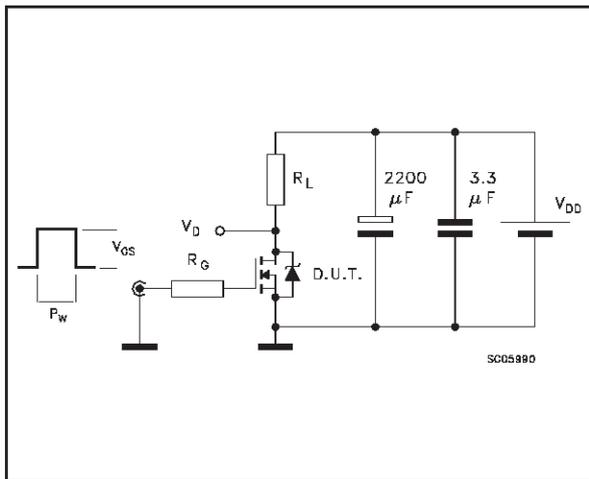
**Fig. 1: Unclamped Inductive Load Test Circuit**



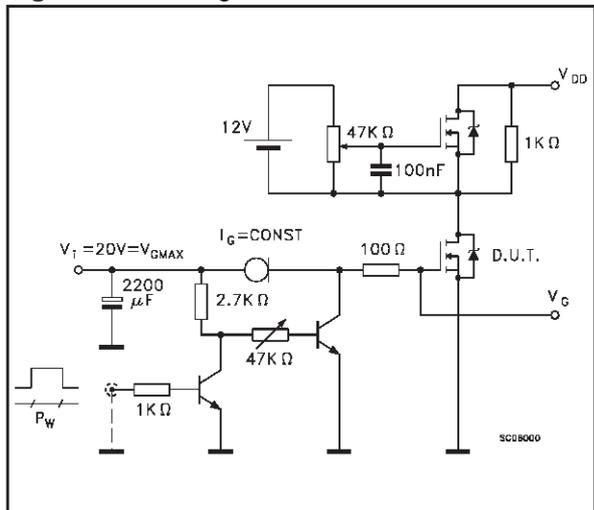
**Fig. 2: Unclamped Inductive Waveform**



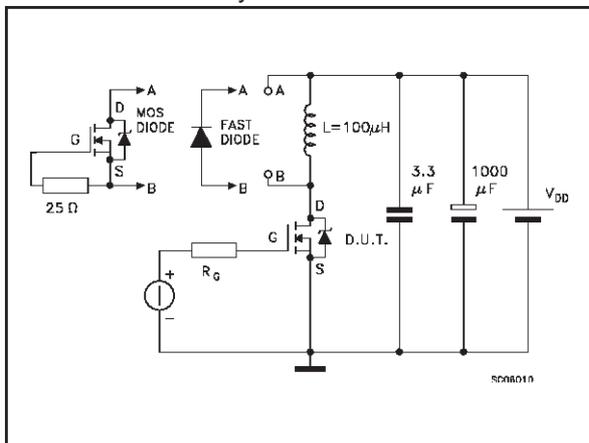
**Fig. 3: Switching Times Test Circuits For Resistive Load**



**Fig. 4: Gate Charge test Circuit**

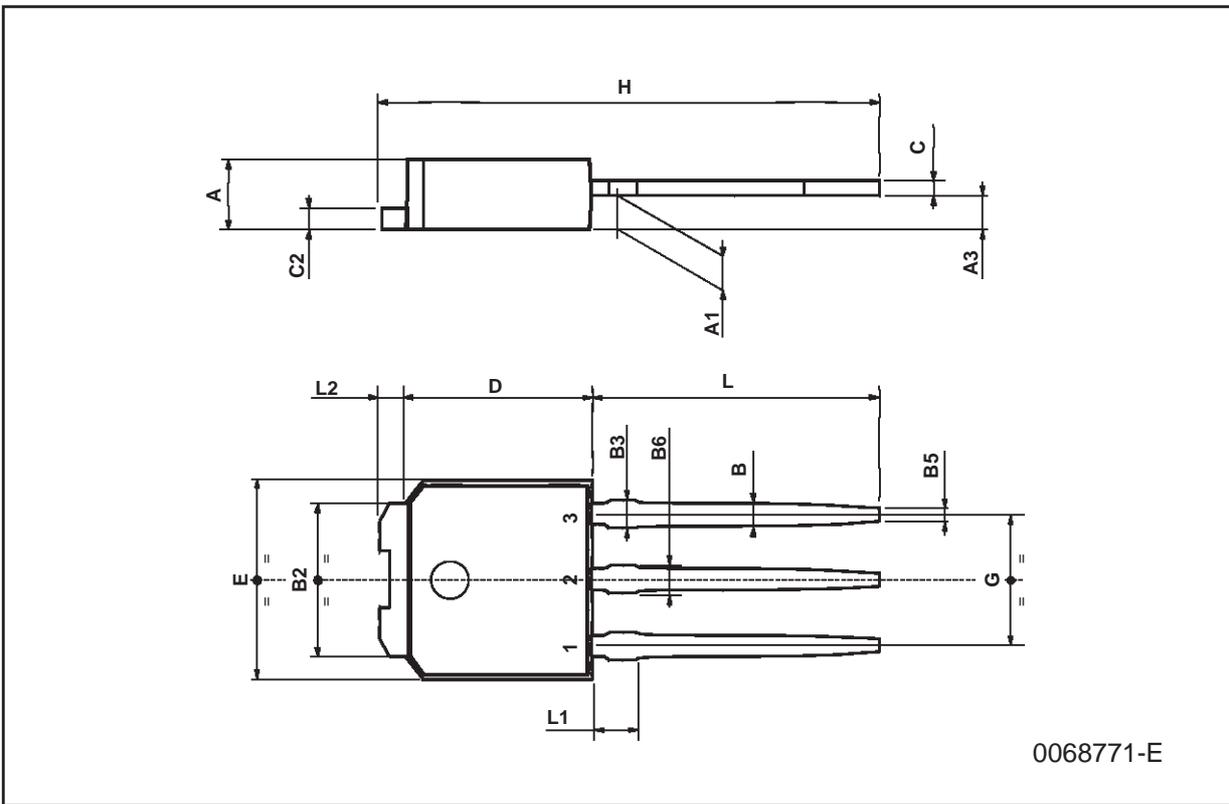


**Fig. 5: Test Circuit For Inductive Load Switching And Diode Recovery Times**



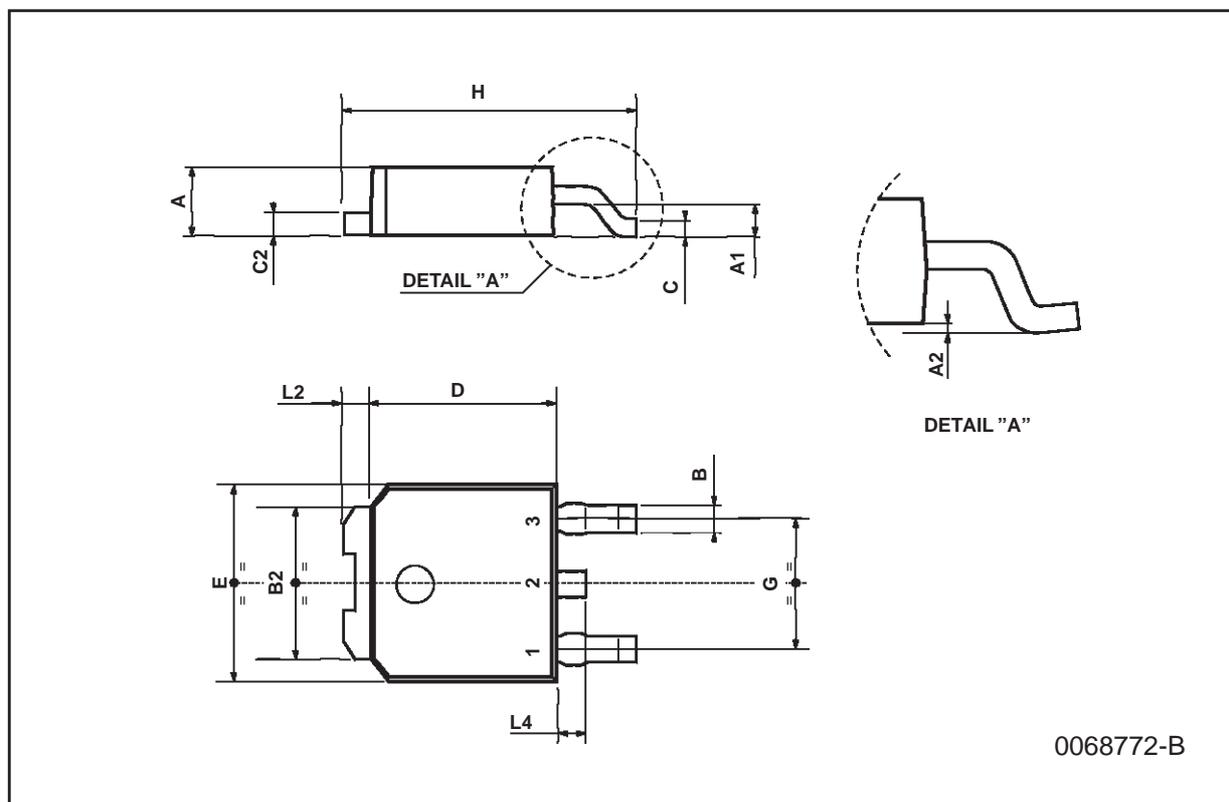
**TO-251 (IPAK) MECHANICAL DATA**

| DIM. | mm   |      |      | inch  |       |       |
|------|------|------|------|-------|-------|-------|
|      | MIN. | TYP. | MAX. | MIN.  | TYP.  | MAX.  |
| A    | 2.2  |      | 2.4  | 0.086 |       | 0.094 |
| A1   | 0.9  |      | 1.1  | 0.035 |       | 0.043 |
| A3   | 0.7  |      | 1.3  | 0.027 |       | 0.051 |
| B    | 0.64 |      | 0.9  | 0.025 |       | 0.031 |
| B2   | 5.2  |      | 5.4  | 0.204 |       | 0.212 |
| B3   |      |      | 0.85 |       |       | 0.033 |
| B5   |      | 0.3  |      |       | 0.012 |       |
| B6   |      |      | 0.95 |       |       | 0.037 |
| C    | 0.45 |      | 0.6  | 0.017 |       | 0.023 |
| C2   | 0.48 |      | 0.6  | 0.019 |       | 0.023 |
| D    | 6    |      | 6.2  | 0.236 |       | 0.244 |
| E    | 6.4  |      | 6.6  | 0.252 |       | 0.260 |
| G    | 4.4  |      | 4.6  | 0.173 |       | 0.181 |
| H    | 15.9 |      | 16.3 | 0.626 |       | 0.641 |
| L    | 9    |      | 9.4  | 0.354 |       | 0.370 |
| L1   | 0.8  |      | 1.2  | 0.031 |       | 0.047 |
| L2   |      | 0.8  | 1    |       | 0.031 | 0.039 |



**TO-252 (DPAK) MECHANICAL DATA**

| DIM. | mm   |      |      | inch  |       |       |
|------|------|------|------|-------|-------|-------|
|      | MIN. | TYP. | MAX. | MIN.  | TYP.  | MAX.  |
| A    | 2.2  |      | 2.4  | 0.086 |       | 0.094 |
| A1   | 0.9  |      | 1.1  | 0.035 |       | 0.043 |
| A2   | 0.03 |      | 0.23 | 0.001 |       | 0.009 |
| B    | 0.64 |      | 0.9  | 0.025 |       | 0.035 |
| B2   | 5.2  |      | 5.4  | 0.204 |       | 0.212 |
| C    | 0.45 |      | 0.6  | 0.017 |       | 0.023 |
| C2   | 0.48 |      | 0.6  | 0.019 |       | 0.023 |
| D    | 6    |      | 6.2  | 0.236 |       | 0.244 |
| E    | 6.4  |      | 6.6  | 0.252 |       | 0.260 |
| G    | 4.4  |      | 4.6  | 0.173 |       | 0.181 |
| H    | 9.35 |      | 10.1 | 0.368 |       | 0.397 |
| L2   |      | 0.8  |      |       | 0.031 |       |
| L4   | 0.6  |      | 1    | 0.023 |       | 0.039 |



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